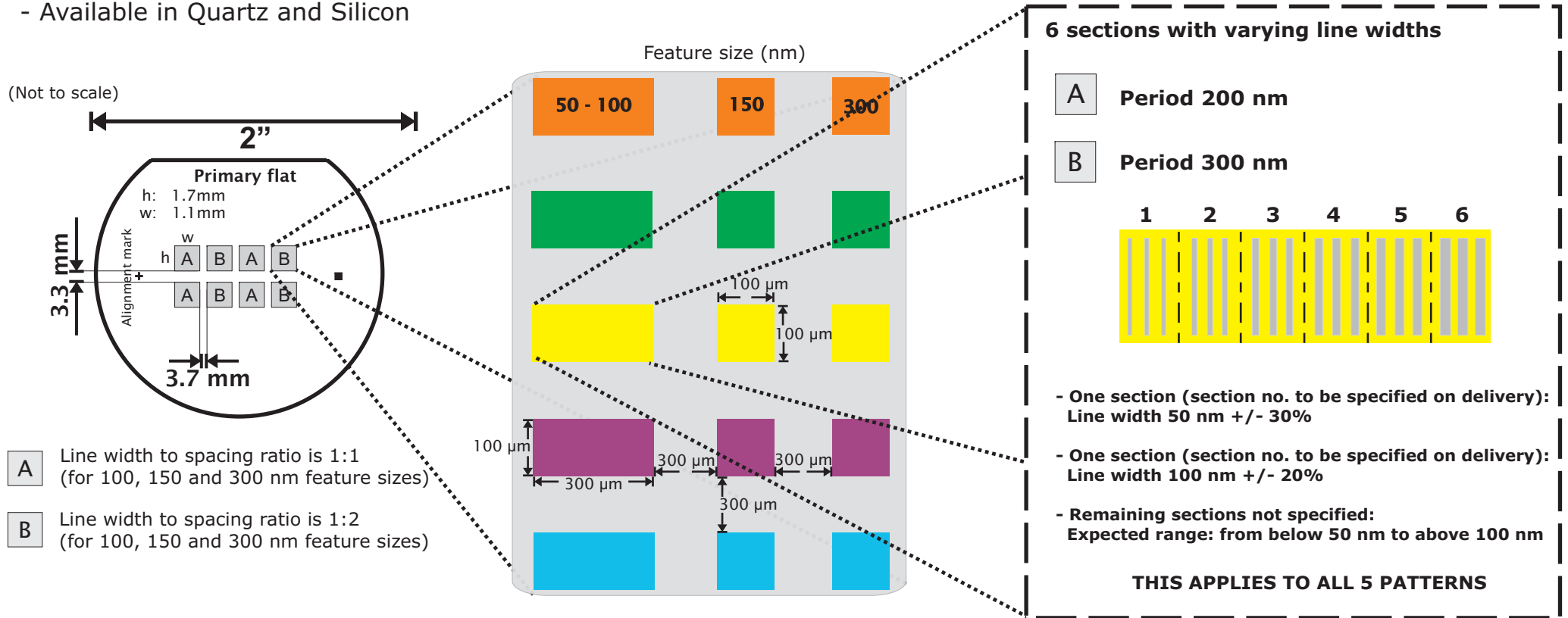


Multi-Pattern Standard Stamp

- Standard structures down to 50 nm
- 5 different patterns (see SEMs below)
- Perfect for testing and optimization
- Available in Quartz and Silicon



- A** Line width to spacing ratio is 1:1
(for 100, 150 and 300 nm feature sizes)
- B** Line width to spacing ratio is 1:2
(for 100, 150 and 300 nm feature sizes)

